Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/619,613	BAE, MOO HO
Examiner	Art Unit
Yan Wei	3768

SEARCHED				
Class	Subclass	Date	Examiner	
600	447	4/5/2007	YW	
73	626	4/5/2007		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>	······································		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Search in eDan	4/4/2007	YW
Text search attached	4/5/2007	YW
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